

# Secondary discharge mitigation by HV scheme optimisation

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for the ALICE TPC Upgrade Collaboration

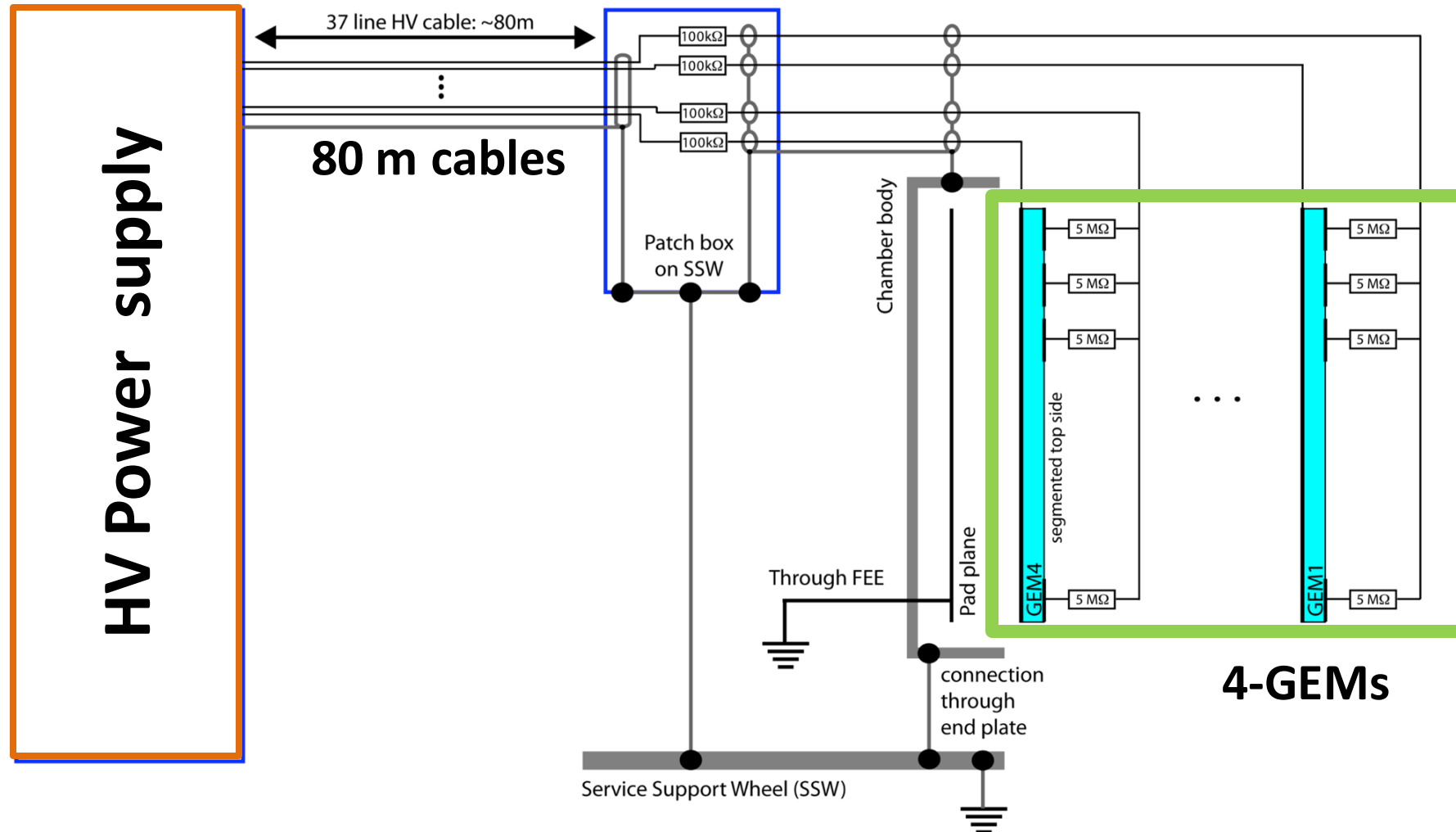


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# Motivation

- Secondary discharges appear shortly after primary discharges
  - Large signal can be associated with a development of a spark between GEM and GEM/padplane
  - See previous talks for physics introduction
  - May be violent and harmful to hardware and electronics
- > Avoid or mitigate secondary discharges
- > Optimise HV scheme

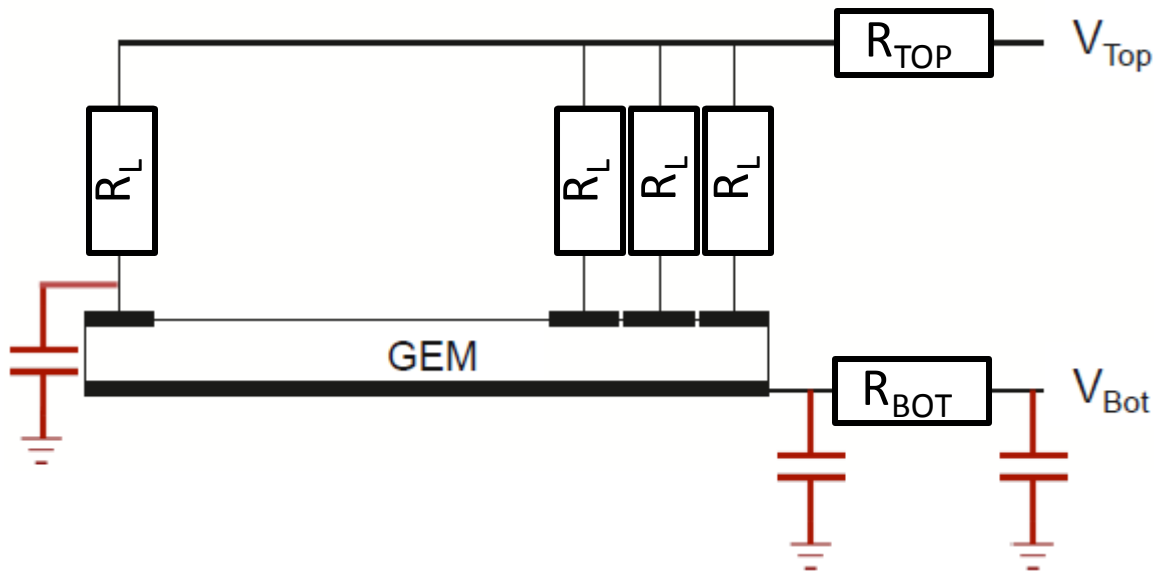
# Upgraded ALICE TPC HV Scheme



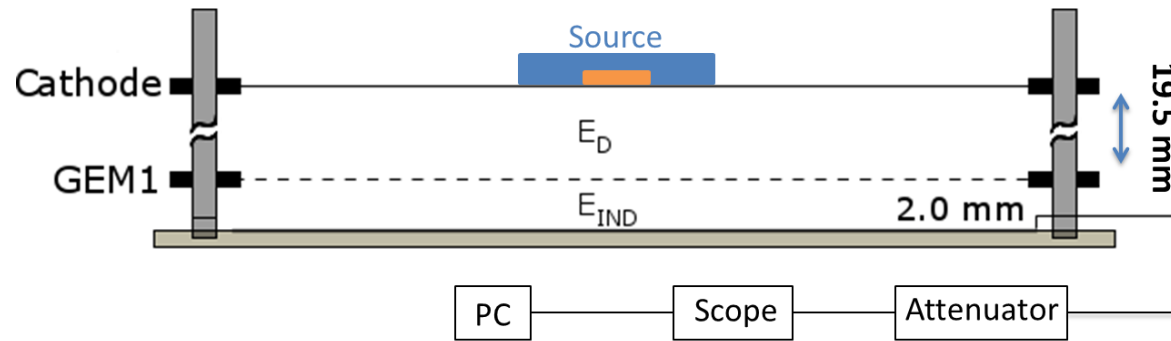
# Optimising HV Scheme

## RC Elements in ALICE GEMs:

- Decoupling resistors  $R_{\text{BOT}} / R_{\text{TOP}}$  (1 per GEM side and HV cable)
  - Decouple HV supply line from a GEM electrode
  - Current choice: 100 k $\Omega$ ; acceptable potential drop
- Parasitic Capacitance due to cables between
  - Power supply and decoupling resistors
  - GEM and decoupling resistors
- Loading resistors  $R_L$  (at top side)
  - Quenching sparks, reduce current, protect GEM segment
  - Reduce current flowing from the PS in case of a short
  - Voltage (thus gain) drop due to the (ion/electron) current
  - **Final choice:** 5 M $\Omega$  (for GEM1/2/3/4)



# Experimental Setup



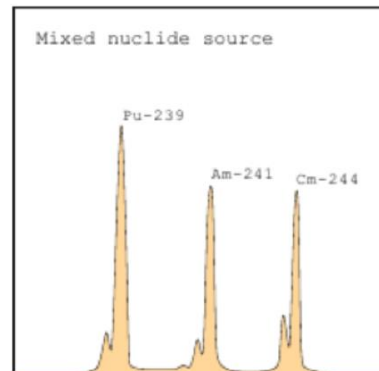
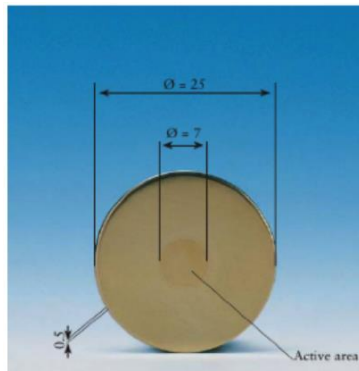
Mixed  $\alpha$ -source (Pu, Am, Cm) shooting through 7 mm hole in the cathode  
Rate  $\sim 550$  Hz

$E_{\text{DRIFT}} = 400$  V/cm (ALICE drift field value)

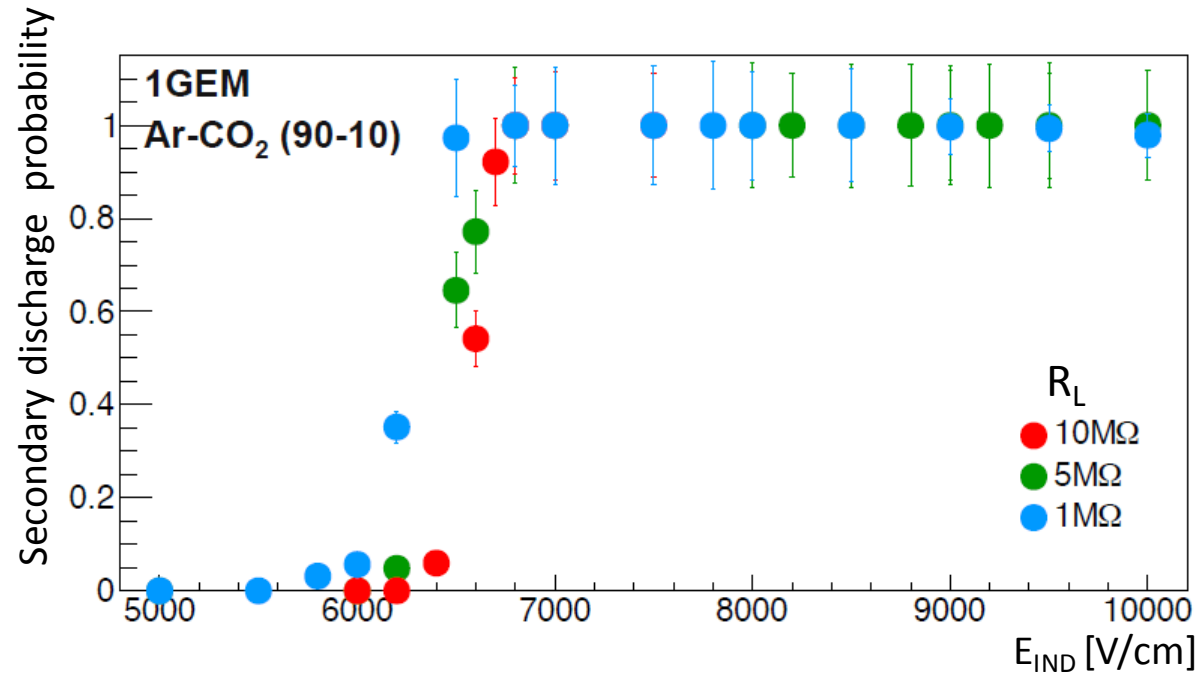
$E_{\text{IND}}$  variable

Readout signals at the anode 34 dB attenuator and a scope

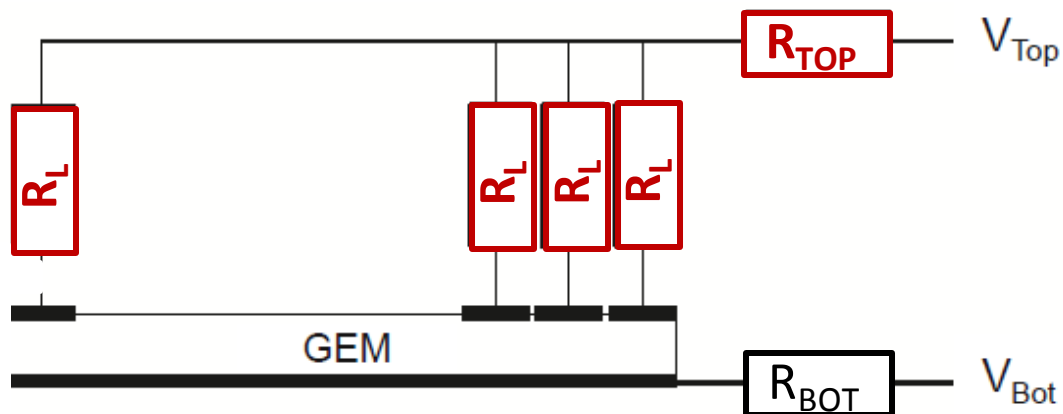
Operated in Ar-CO<sub>2</sub> (90-10) and Ne-CO<sub>2</sub>-N<sub>2</sub> (90-10-5)



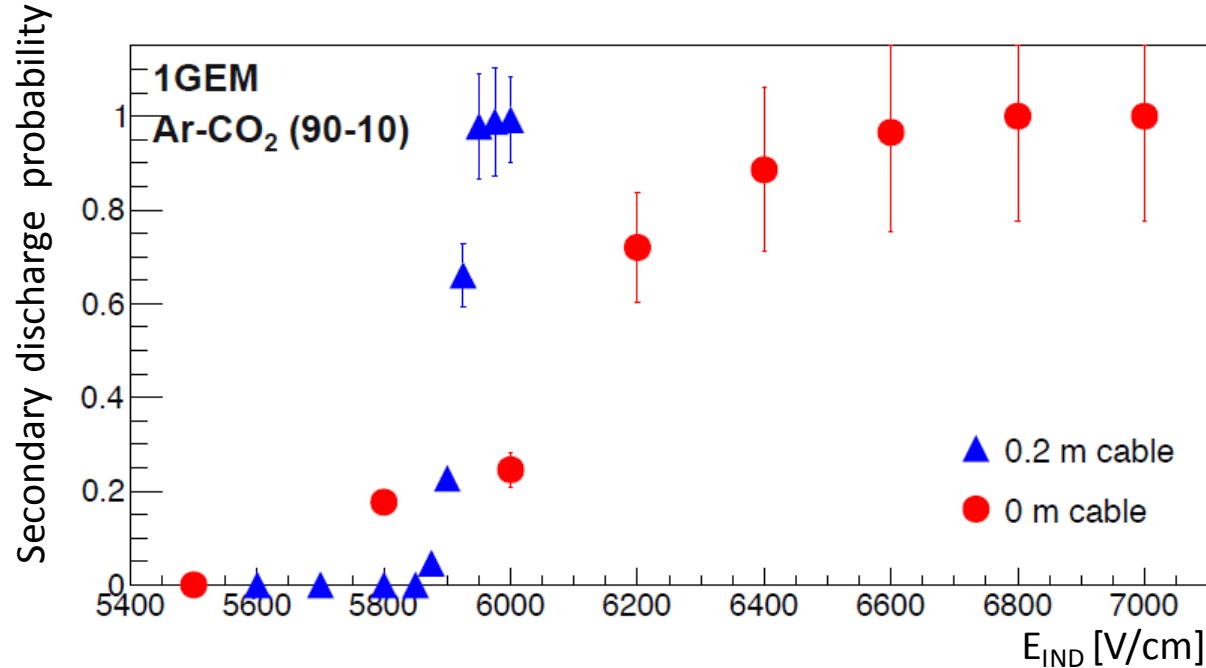
# Parasitic Measurements in Ar-CO<sub>2</sub> (90-10)



- Propagation probability does not depend on the loading resistor value
- Nominal value  $R_L = 5\text{ M}\Omega$

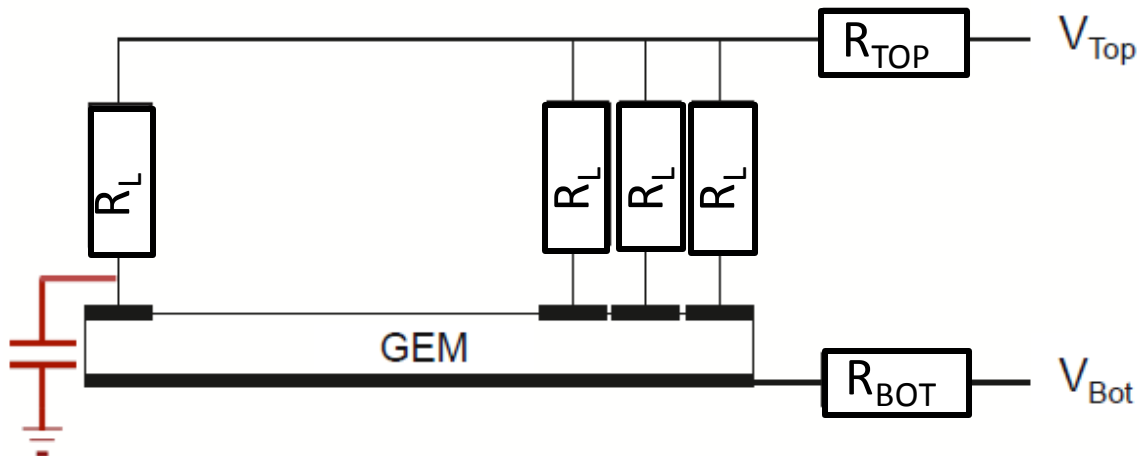


# Parasitic Measurements in Ar-CO<sub>2</sub> (90-10)

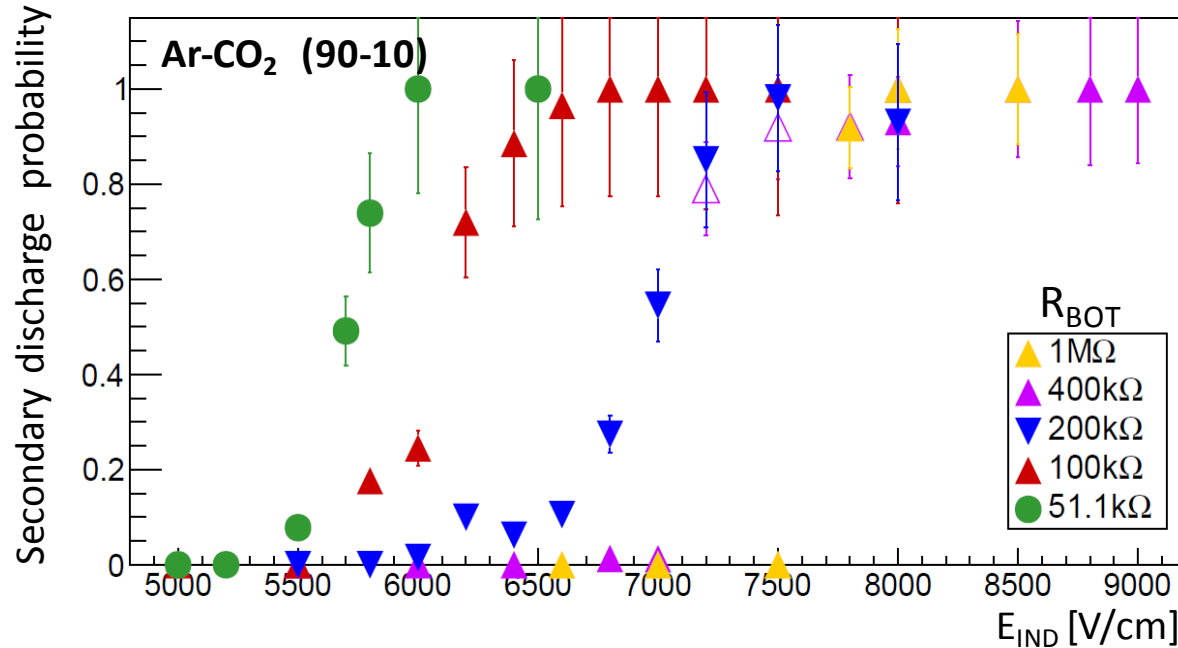


- Extra capacitance (e.g. cable) between the top loading resistor and the top GEM electrode may influence the propagation behavior
- Effect of an extra energy reservoir causes increase of GEM bottom voltage

=> Loading resistors soldered directly at GEM foil

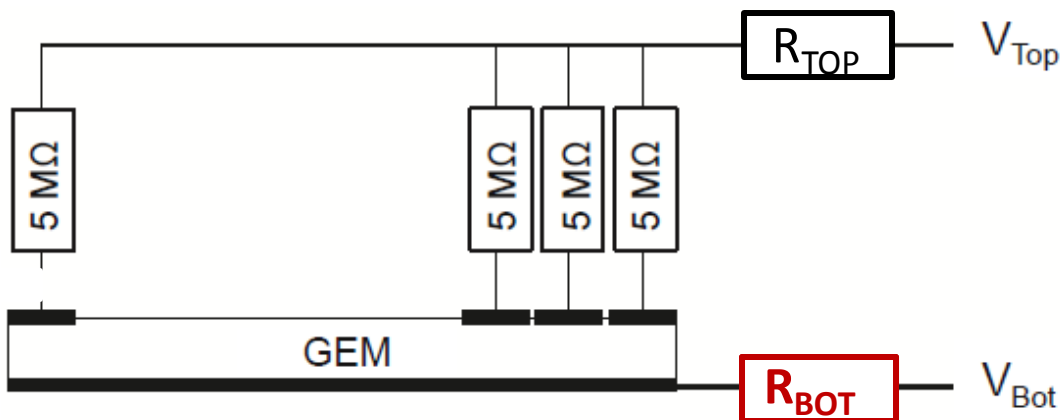


# Parasitic Measurements in Ar-CO<sub>2</sub> (90-10)



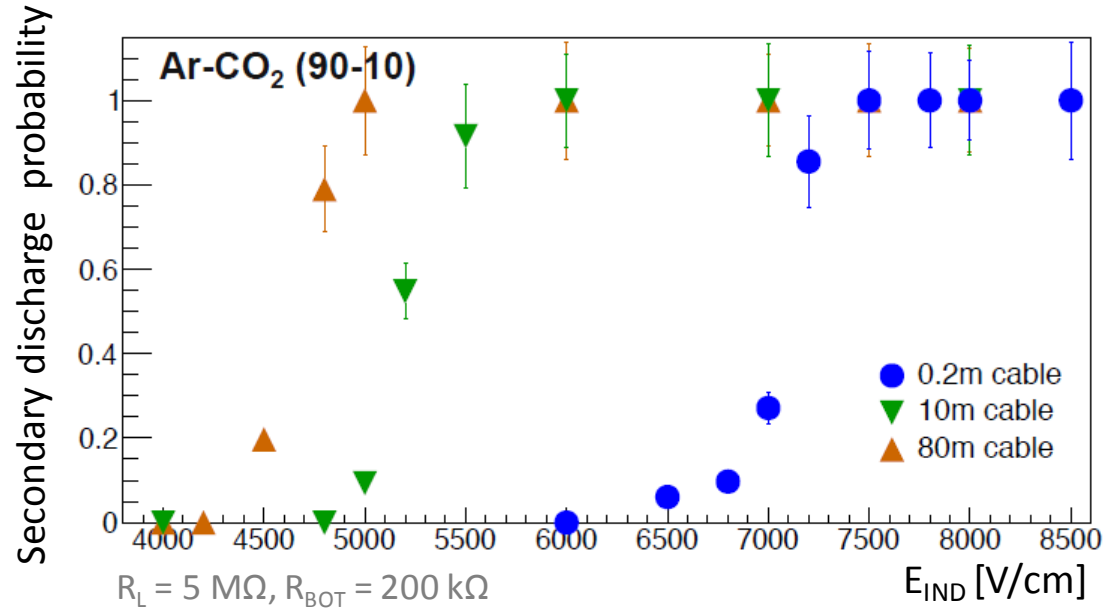
- Onset of propagation observed at higher  $E_{IND}$  for larger  $R_{BOT}$
- Clear recommendation to maximize  $R_{BOT}$
- But high  $R_{BOT}$  leads to gain drop

⇒ Balance  $R_{BOT}$  between secondary discharge probability and gain drop

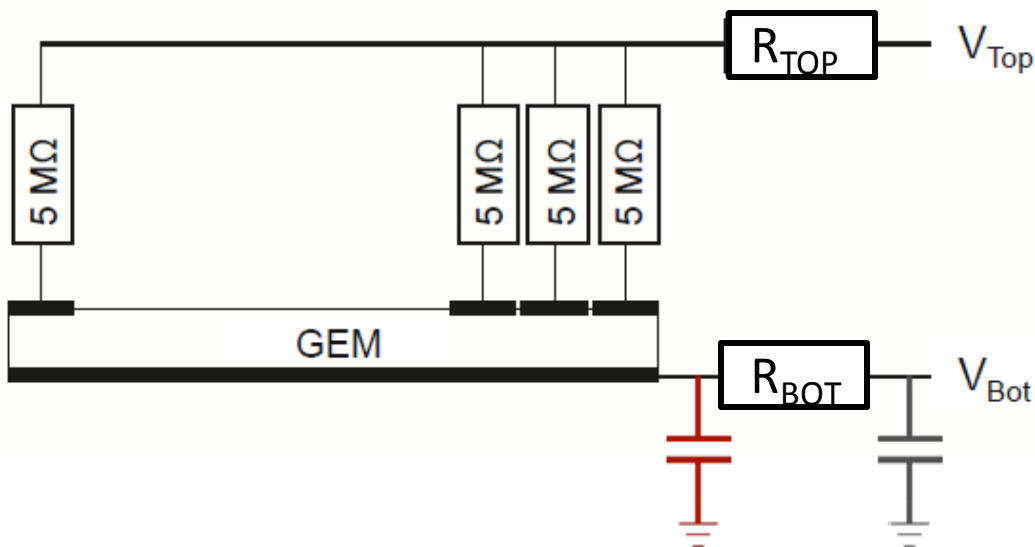




# Parasitic Measurements in Ar-CO<sub>2</sub> (90-10)

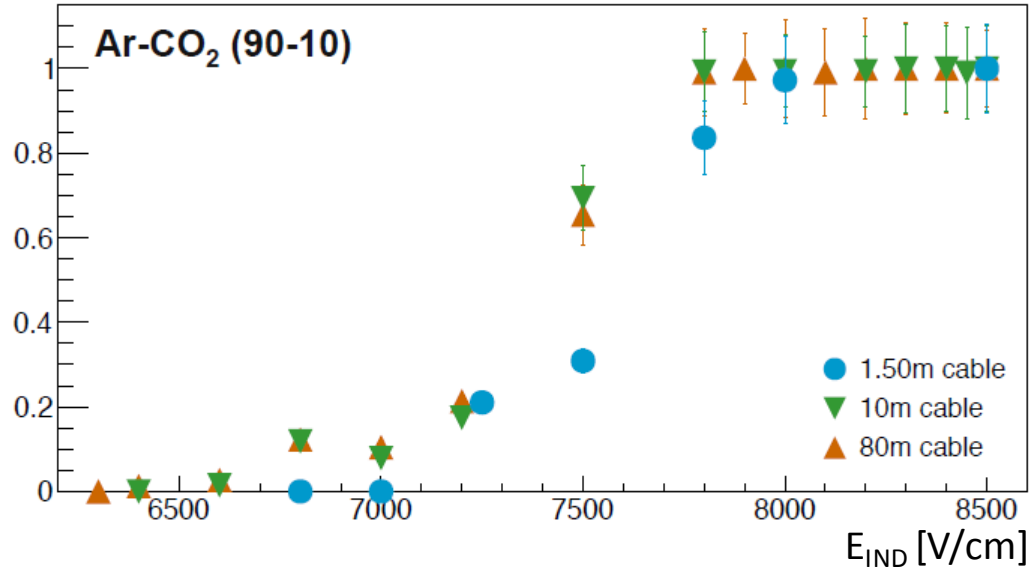


- Cables introduce parasitic capacitance
- Propagation probability increases with length of cable between  $R_{BOT}$  and GEM
- Effect of stored energy
- Necessary to install decoupling resistors close to chambers (clear preference  $R_{BOT}$  &  $R_{TOP} = 100 \text{ k}\Omega$ )



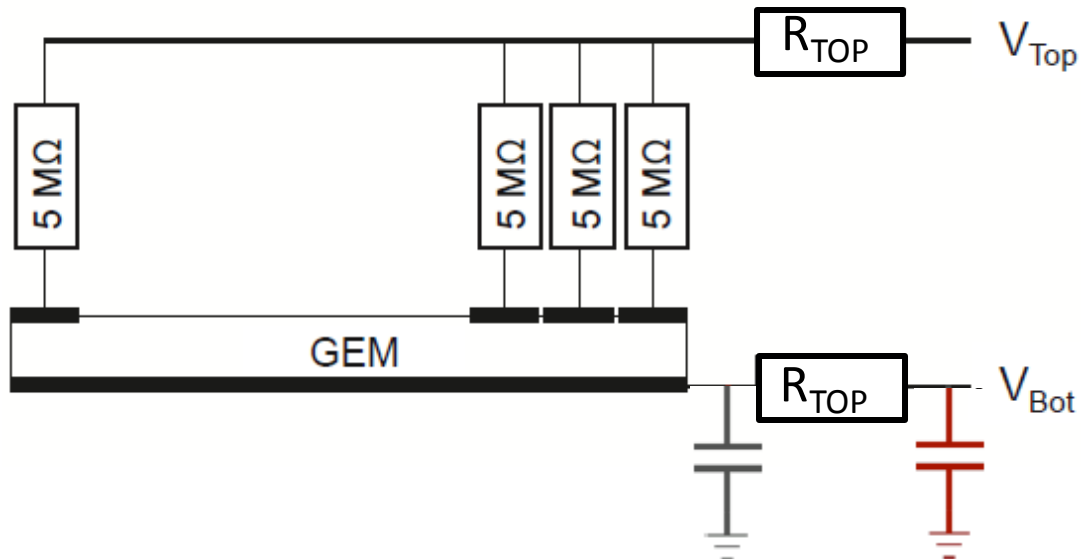
# Parasitic Measurements in Ar-CO<sub>2</sub> (90-10)

Secondary discharge probability

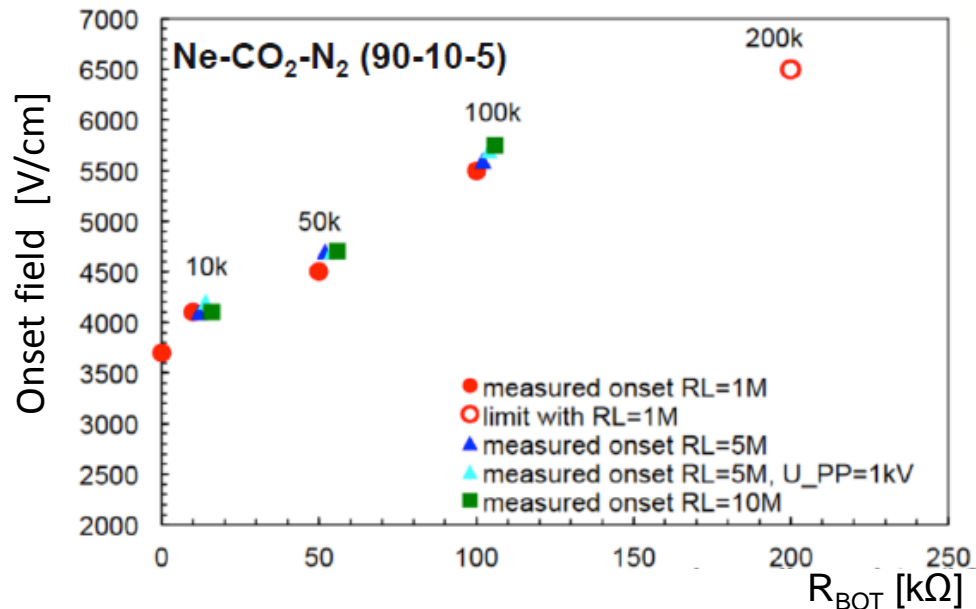
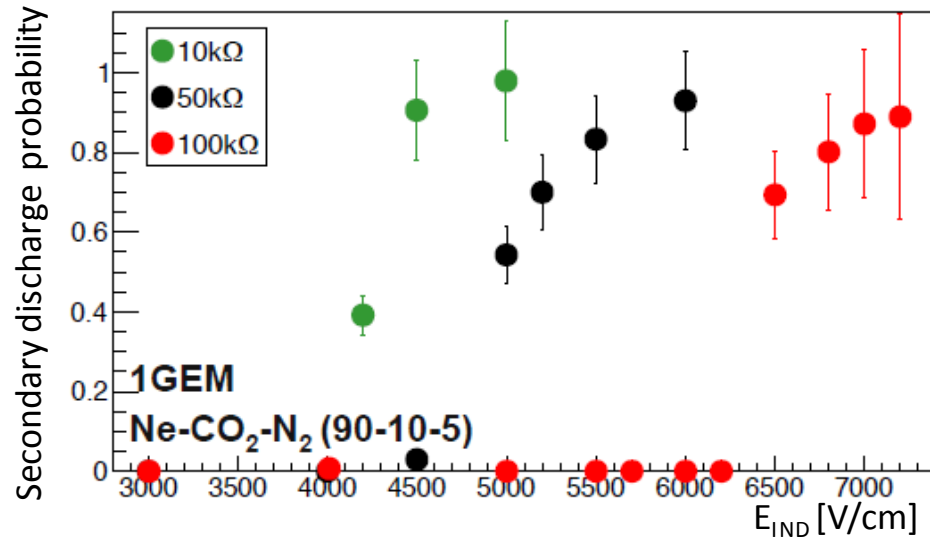


- Effect of decoupling resistor ( $R_{BOT} = 200 \text{ k}\Omega$ ,  $R_L = 5 \text{ M}\Omega$ )
- Cable length (between the PS and  $R_{BOT}/R_{TOP}$ ) does not influence the propagation probability

$\Rightarrow R_{BOT}$  decouples long cables well

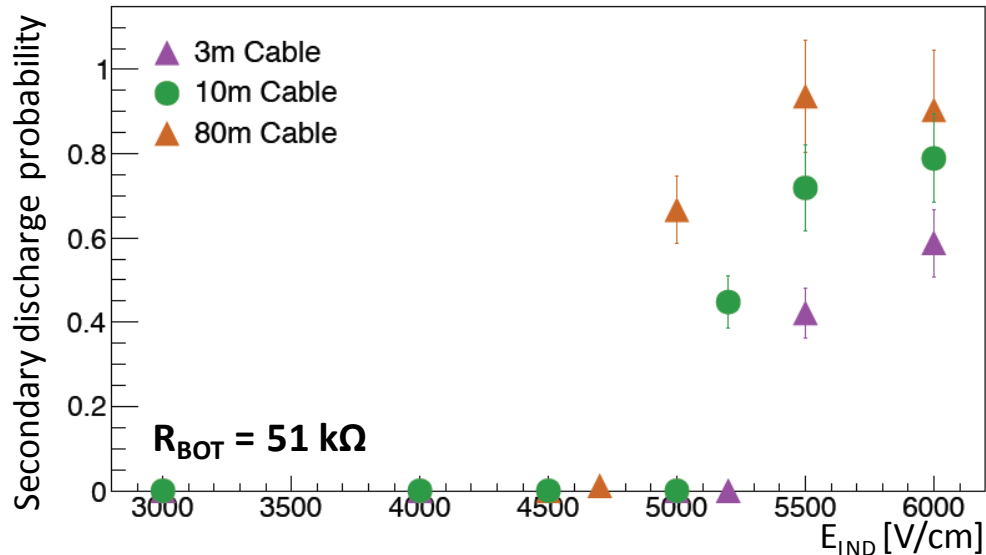
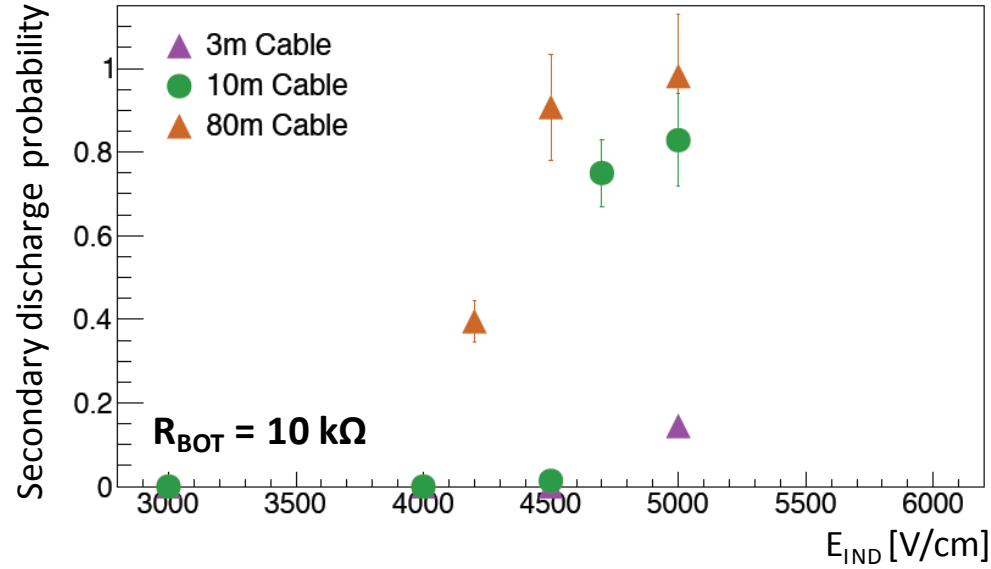


# Measurements in Ne-CO<sub>2</sub>-N<sub>2</sub> (90-10-5)

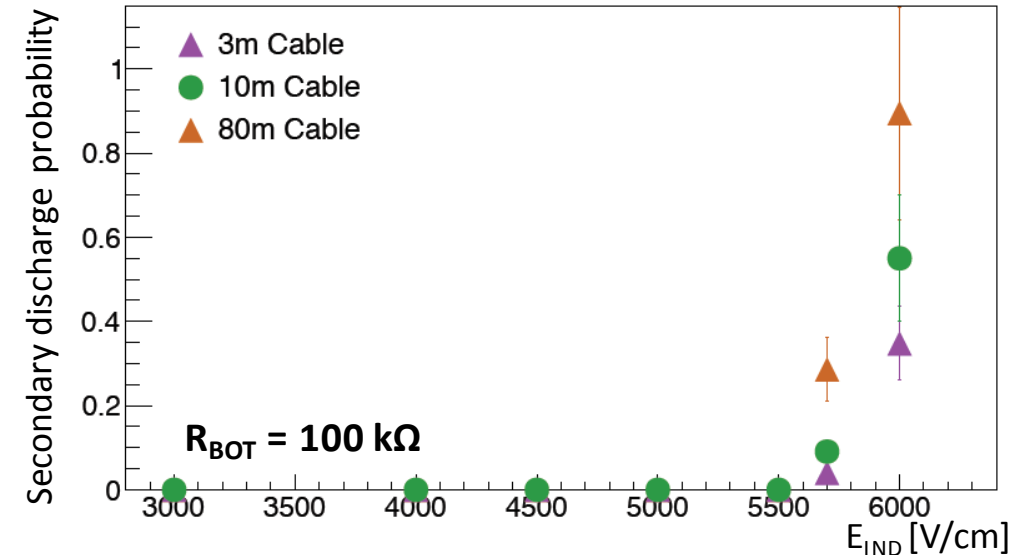


- Propagation curve measured in future ALICE TPC gas mixture
- 80 m cable from the power supply to simulate realistic conditions
- 1.5 m between  $R_{BOT}$  and GEM bottom
- Clear dependence on  $R_{BOT}$  value

# Measurements in Ne-CO<sub>2</sub>-N<sub>2</sub> (90-10-5)



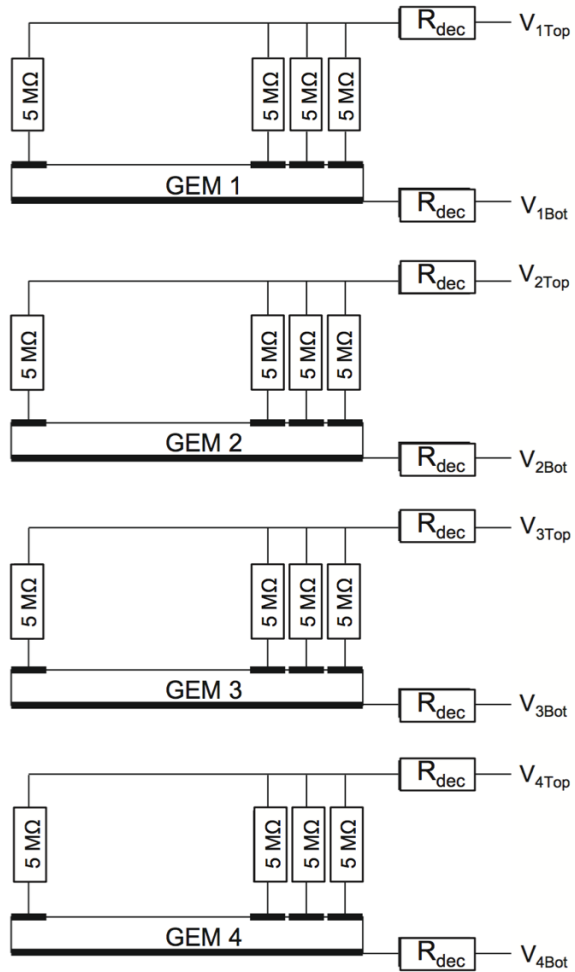
- Visible dependence on cable length for low  $R_{BOT}$
- Situation improves with larger  $R_{BOT}$
- With  $R_{BOT} > 100 \text{ k}\Omega$  marginal dependency on the cable length
- Higher resistance clearly preferable



# Summary I

- RC components clearly have a major influence on discharge propagation
- Solder  $R_L$  directly to GEM
- Choose high value of the decoupling resistance:  $R_{BOT} = 100 \text{ k}\Omega$ 
  - Value of the resistor can be adjusted until final installation but also during the TPC operation
- HV settings with lower fields preferable
- Minimize cable length between the  $R_{BOT}$  and GEM (~2 m)

# Application to 4-GEM Setup



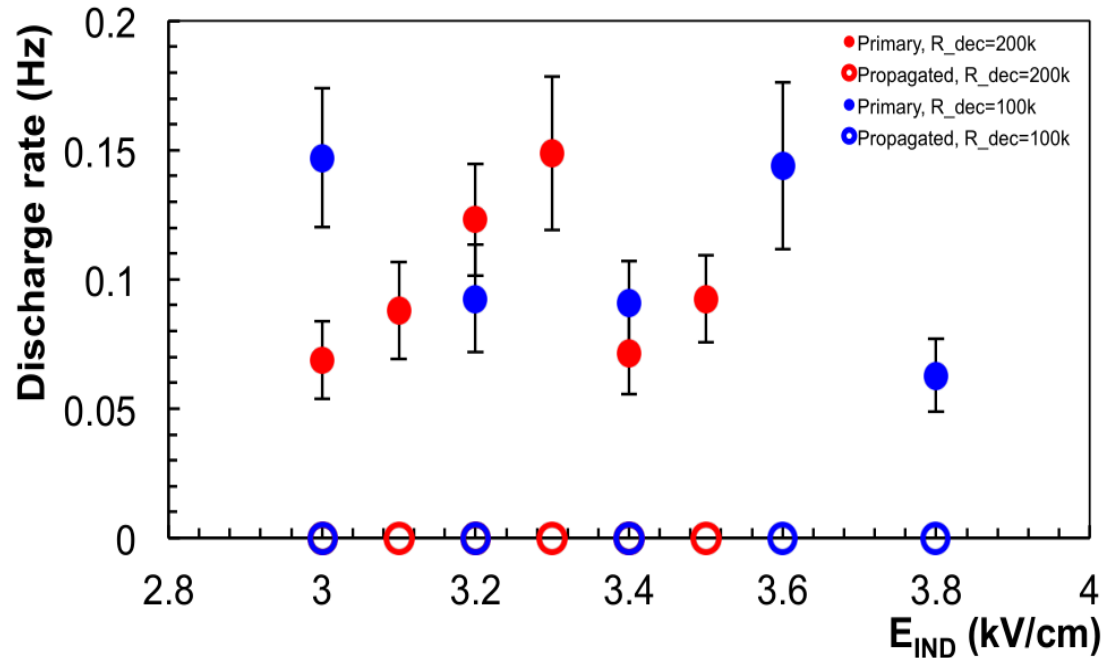
- So far all systematic measurements with 1-GEM setup
- Now: Application of “propagation-hardened” HV scheme on 4-GEM Setup
- Trigger sparks with  $\Delta V_{\text{GEM}} > 380 \text{ V}$  (much higher than nominal setting)

	GEM1	GEM2	GEM3	GEM4
$\Delta V_{\text{GEM}}$	270 V	230 V	320 V	320 V
Field below GEM	3.5 kV/cm	3.5 kV/cm	0.1 kV/cm	3.5 kV/cm

Baseline ALICE settings

Readout

# Application to 4-GEM Setup



- GEM 4 studies show that optimized HV scheme works as intended, no propagations to the readout plane
- However secondary discharges (in transfer gaps) still observed when primary discharge triggered in GEM 1/2/3
- Proper trip limits and 100 k $\Omega$  secure GEMs (no GEM was broken when  $R_{BOT} > 0$ )
- Further stabilisation by:
  - Reduction of transfer/induction fields (performance deterioration, higher  $\Delta V_{GEM}$  necessary to compensate gain)
  - Increase  $R_{BOT}$  value for GEM 1/2/3 (200-500 k $\Omega$ ) (gain drop is not an issue as the highest amplification occurs in GEM 4)

# Summary II

- GEM 4 safe, propagation still visible in GEM 1/2/3  
⇒ Solutions: higher  $R_{\text{BOT}}$ , lower  $E_{\text{IND}}$  (but lower  $E_{\text{IND}}$  necessitates higher  $\Delta V_{\text{GEM}}$ )
- Due to our rule set no GEMs were harmed during these studies

Next up:

- Measure multi-GEM propagation with final power supply and full-size IROC